
PXle-4145

Specifications

2022-07-06



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PXIe-4145 Specifications

These specifications apply to the PXIe-4145.

Definitions

Warranted specifications describe the performance of a model under stated operating conditions and are covered by the model warranty.

Characteristics describe values that are relevant to the use of the model under stated operating conditions but are not covered by the model warranty.

- **Typical** specifications describe the performance met by a majority of models.
- **Nominal** specifications describe an attribute that is based on design, conformance testing, or supplemental testing.

Specifications are **Warranted** unless otherwise noted.

Conditions

Specifications are valid under the following conditions unless otherwise noted.

- Ambient temperature^[1] of $23\text{ °C} \pm 5\text{ °C}$
- Calibration interval of 1 year
- 30 minutes warm-up time
- Self-calibration performed within the last 24 hours
- niDCPower Aperture Time property or NIDCPOWER_ATTR_APERTURE_TIME attribute set to 2 power-line cycles (PLC)
- Fans set to the highest setting if the PXI Express chassis has multiple fan speed settings

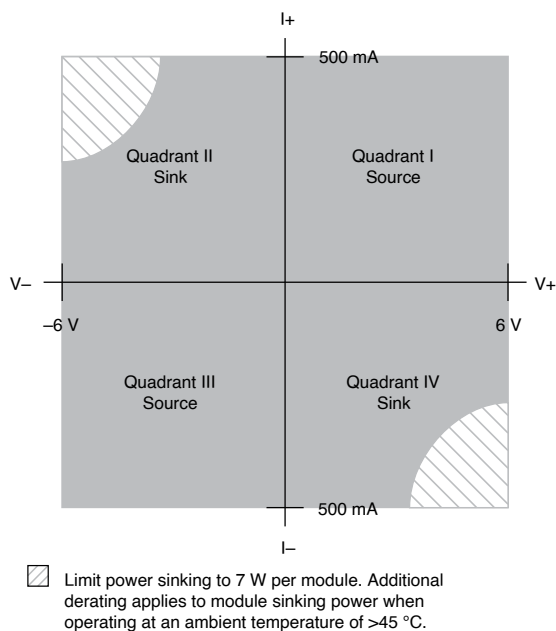
Device Capabilities

The following table and figure illustrate the voltage and the current source and sink ranges of the PXIe-4145.

Channels	DC Voltage Ranges	DC Current Source and Sink Ranges
0 through 3	± 6 V	<ul style="list-style-type: none"> ▪ 10 μA ▪ 100 μA ▪ 1 mA ▪ 10 mA ▪ 100 mA ▪ 500 mA

Table 1. PXIe-4145 Current Source and Sink Ranges

Figure 1. PXIe-4145 Quadrant Diagram, All Channels



SMU Specifications

Voltage Programming and Measurement Accuracy/Resolution

Range	Resolution and noise (0.1 Hz to 10 Hz)	1 Year Accuracy (23 °C ± 5 °C) ± (% of voltage + offset)		Tempco ± (% of voltage + offset)/°C, 0 °C to 55 °C
		T _{cal} ± 5 °C	T _{cal} ± 1 °C	
6 V	6 μV	0.015% + 600 μV	0.013% + 200 μV	0.0005% + 1 μV

Table 2. Voltage Programming and Measurement Accuracy/Resolution

Related tasks

- [Calculating SMU Resolution](#)

Related reference

- [Additional Specifications](#)

Current

Range	Resolution and noise (0.1 Hz to 10 Hz)	1 Year Accuracy (23 °C ± 5 °C) ± (% of current + offset)		Tempco ± (% of current + offset)/°C, 0 °C to 55 °C
		T _{cal} ± 5 °C	T _{cal} ± 1 °C	
10 μA	15 pA	0.03% + 3 nA	0.03% + 1.2 nA	0.002% + 20 pA
100 μA	100 pA	0.03% + 25 nA	0.03% + 6.0 nA	0.002% + 200 pA
1 mA	1 nA	0.03% + 250 nA	0.03% + 60 nA	0.002% + 2.0 nA
10 mA	10 nA	0.03% + 2.5 μA	0.03% + 600 nA	0.002% + 20 nA
100 mA	100 nA	0.03% + 25 μA	0.03% + 6.0 μA	0.002% + 200 nA
500 mA	500 nA	0.1% + 125 μA	0.1% + 30 μA	0.008% + 1 μA

Table 3. Current Programming and Measurement Accuracy/Resolution

Related tasks

- [Calculating SMU Resolution](#)

Related reference

- [Additional Specifications](#)

Output Resistance Programming Accuracy/Resolution, Typical

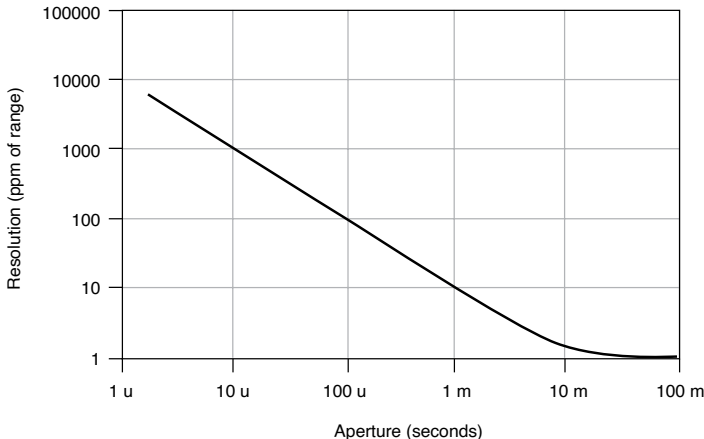
Current limit range	Programmable resistance range	Resolution	Accuracy ± (% of resistance setting), $T_{cal} \pm 5^\circ C$
10 μA	± 50 k Ω	1.0 Ω	0.04% + 260 m Ω
100 μA	± 5 k Ω	100 m Ω	0.04% + 35 m Ω
1 mA	± 500 Ω	10 m Ω	0.04% + 13 m Ω
10 mA	± 50 Ω	1.0 m Ω	0.04% + 10 m Ω
100 mA	± 5 Ω	100 $\mu\Omega$	0.04% + 10 m Ω
500 mA	± 1 Ω	20 $\mu\Omega$	0.12% + 10 m Ω

Table 4. Output Resistance Programming Accuracy/Resolution, Typical

Calculating SMU Resolution

Refer to the following figure as you complete the following steps to derive a resolution in absolute units:

Figure 1. Noise and Resolution versus Measurement Aperture, Typical



1. Select a voltage or current range.
2. For a given aperture time, find the corresponding resolution.
3. To convert resolution from ppm of range to absolute units, multiply resolution in ppm of range by the selected range.

Example of Calculating SMU Resolution

The PXIe-4145 has a resolution of 100 ppm when set to a 100 μs aperture time. In the 6 V range, resolution can be calculated by multiplying 6 V by 100 ppm, as shown in the following equation:

$$6 \text{ V} * 100 \text{ ppm} = 6 \text{ V} * 100 * 1 \times 10^{-6} = 600 \mu\text{V}$$

Likewise, in the 10 mA range, resolution can be calculated by multiplying 10 mA by 100 ppm, as shown in the following equation:

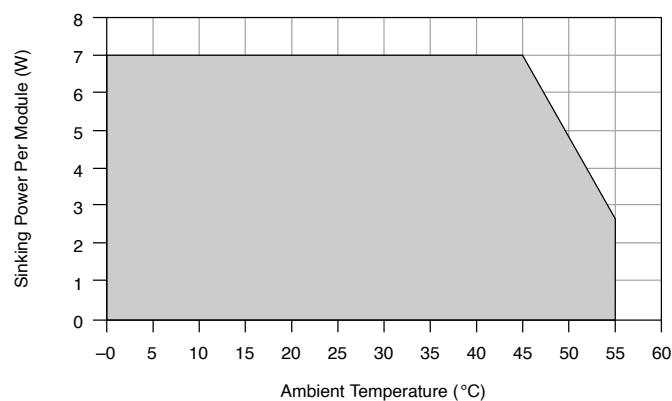
$$10 \text{ mA} * 100 \text{ ppm} = 10 \text{ mA} * 100 * 1 \times 10^{-6} = 1 \mu\text{A}$$

Sinking Power vs. Ambient Temperature Derating

The following figure illustrates sinking power derating as a function of ambient temperature.

This applies to the PXIe-4145 (40W) when used with any chassis and only applies to the PXIe-4145 (40W) when used with a chassis with slot cooling capacity <58W.

Figure 1. Sinking Power vs Ambient Temperature Derating



Note When using the PXIe-4145 (40W) with a chassis with slot cooling capacity $\geq 58\text{W}$, ambient temperature derating does not apply.

Additional Specifications

Settling time ^[3]	<100 μ s to settle to 0.1% of voltage step, device configured for fast transient response, typical
Transient response	<100 μ s to recover within \pm 20 mV after a load current change from 10% to 90% of range, device configured for fast transient response, typical
Wideband source noise ^[4]	1.5 mV RMS, typical <20 mV _{pk-pk} , typical
Cable guard output impedance	10 k Ω , typical
<p>Remote sense</p> <p>Voltage Add 0.1% of LO lead drop to voltage accuracy specification</p> <p>Current No additional error due to lead drop</p> <p>Maximum lead drop Up to 1 V drop per lead for $V_{out} \leq 5$ V. For $V_{out} > 5$ V, keep sum of V_{out} and total lead drop below 7 V</p>	
<p>Load regulation</p> <p>Voltage 10 μV at connector pins per mA of output load when using local sense, typical</p> <p>Current 20 pA + (1 ppm of range per volt of output change) when using local sense, typical</p>	
Isolation voltage, Channel-to-earth ground	60 VDC, CAT I, verified by dielectric withstand test, 5 s, continuous, characteristic

Absolute maximum voltage between any terminal and LO	20 VDC, continuous
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The following figures illustrate the effect of the transient response setting on the step response of the PXIe-4145 for different loads.

Figure 1. 1 mA Range No Load Step Response, Typical

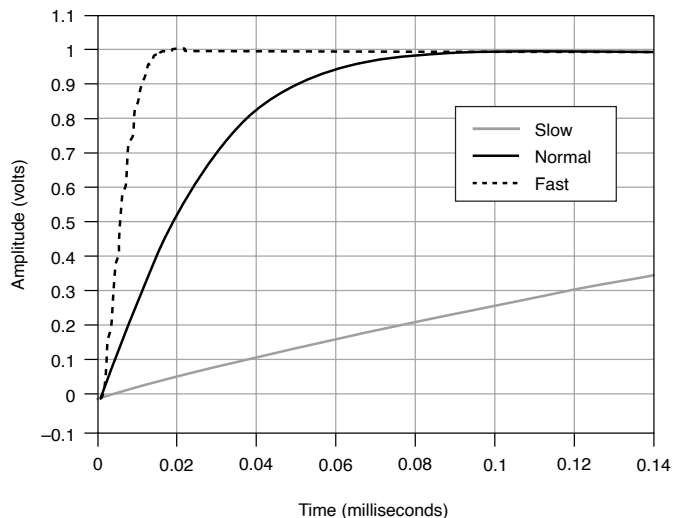
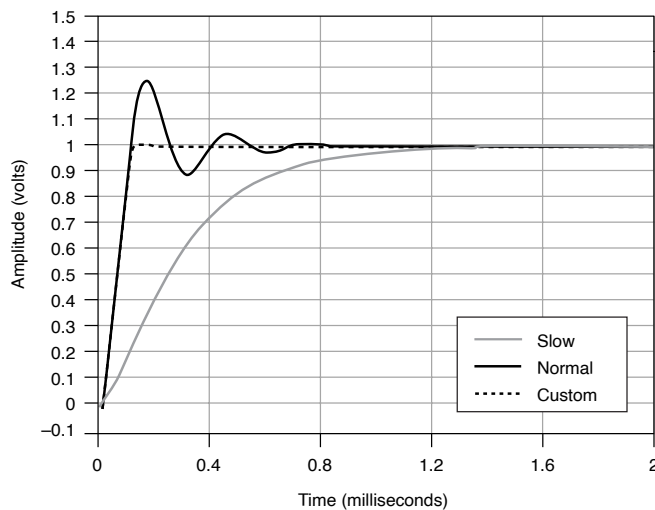


Figure 1. 1 mA Range, 100 nF Load Step Response, Typical



Related reference

- [Voltage Programming and Measurement Accuracy/Resolution](#)
- [Current](#)

Supplemental Specifications

Measurement and Update Timing

Available sample rates ^[5]	$(600 \text{ kS/s})/\mathbf{N}$
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where

- $\mathbf{N} = 6, 7, 8, \dots 2^{20}$
- S is samples

Sample rate accuracy	$\pm 50 \text{ ppm}$
Maximum measure rate to host ^[6]	600,000 S/s per channel, continuous

Maximum source update rate^[7]

Sequence length < 300 steps per iteration	100,000 updates/s per channel
Sequence length ≥ 300 steps per iteration	100,000 updates/s per board

Input trigger to

Source event delay	5 μs
Source event jitter	1.7 μs
Measure event jitter	1.7 μs

Triggers

Input triggers

Types	Start
	Source
	Sequence Advance
	Measure

Sources (PXI trigger lines 0 to 7)^[8]

Polarity	Active high (not configurable)
Minimum pulse width	100 ns

Destinations^[9] (PXI trigger lines 0 to 7)^[8]

Polarity	Active high (not configurable)
Minimum pulse width	>200 ns

Output triggers (events)

Types	Source Complete
	Sequence Iteration Complete
	Sequence Engine Done
	Measure Complete

Destinations (PXI trigger lines 0 to 7)^[8]

Polarity	Active high (not configurable)
Pulse width	230 ns

Calibration Interval

Recommended calibration interval	1 year
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Physical

Dimensions	3U, one-slot, PXI Express/CompactPCI Express module 2.0 cm × 13.0 cm × 21.6 cm (0.8 in. × 5.1 in. × 8.5 in.)
Weight	
20 W	408 g (14.39 oz)
40 W	428 g (15.1 oz)
Front panel connectors	25-position D-SUB, male

Power Requirement

PXIe-4145 (40W)	3.0 A from the 3.3 V rail and 6.0 A from the 12 V rail
PXIe-4145 (20W)	2.5 A from the 3.3 V rail and 2.7 A from the 12 V rail

Environment

Maximum altitude	2,000 m (800 mbar) (at 25 °C ambient temperature)
Pollution Degree	2

Indoor use only.

Operating Environment

Ambient temperature range	0 °C to 40 °C
Relative humidity range	10% to 70%, noncondensing; derate 1.3% per °C above 40 °C (Tested in accordance with IEC 60068-2-56.)

Storage Environment

Ambient temperature range	-40 °C to 70 °C
Relative humidity range	5% to 95%, noncondensing

Shock and Vibration

Operating shock	30 g peak, half-sine, 11 ms pulse
Random vibration	
Operating	5 Hz to 500 Hz, 0.3 g _{rms}
Nonoperating	5 Hz to 500 Hz, 2.4 g _{rms}

Compliance and Certifications

Safety Compliance Standards

This product is designed to meet the requirements of the following electrical equipment safety standards for measurement, control, and laboratory use:

- IEC 61010-1, EN 61010-1
- UL 61010-1, CSA C22.2 No. 61010-1



Note For safety certifications, refer to the product label or the [Product Certifications and Declarations](#) section.

Electromagnetic Compatibility

This product meets the requirements of the following EMC standards for electrical equipment for measurement, control, and laboratory use:

- EN 61326-1 (IEC 61326-1): Class A emissions; Basic immunity
- EN 55011 (CISPR 11): Group 1, Class A emissions
- EN 55022 (CISPR 22): Class A emissions
- EN 55024 (CISPR 24): Immunity
- AS/NZS CISPR 11: Group 1, Class A emissions
- AS/NZS CISPR 22: Class A emissions
- FCC 47 CFR Part 15B: Class A emissions
- ICES-001: Class A emissions



Note In the United States (per FCC 47 CFR), Class A equipment is intended for use in commercial, light-industrial, and heavy-industrial locations. In Europe, Canada, Australia, and New Zealand (per CISPR 11), Class A equipment is intended for use only in heavy-industrial locations.



Note Group 1 equipment (per CISPR 11) is any industrial, scientific, or medical equipment that does not intentionally generate radio frequency energy for the treatment of material or inspection/analysis purposes.



Note For EMC declarations, certifications, and additional information, refer to the [Product Certifications and Declarations](#) section.

Product Certifications and Declarations

Refer to the product Declaration of Conformity (DoC) for additional regulatory compliance information. To obtain product certifications and the DoC for NI


products, visit ni.com/product-certifications, search by model number, and click the appropriate link.

Environmental Management


NI is committed to designing and manufacturing products in an environmentally responsible manner. NI recognizes that eliminating certain hazardous substances from our products is beneficial to the environment and to NI customers.

For additional environmental information, refer to the **Engineering a Healthy Planet** web page at ni.com/environment. This page contains the environmental regulations and directives with which NI complies, as well as other environmental information not included in this document.

EU and UK Customers

-  Waste Electrical and Electronic Equipment (WEEE)—At the end of the product life cycle, all NI products must be disposed of according to local laws and regulations. For more information about how to recycle NI products in your region, visit ni.com/environment/weee.

电子信息产品污染控制管理办法 (中国 RoHS)

-  中国 RoHS— NI 符合中国电子信息产品中限制使用某些有害物质指令(RoHS)。关于 NI 中国 RoHS 合规性信息，请登录 ni.com/environment/rohs_china。(For information about China RoHS compliance, go to ni.com/environment/rohs_china.)

¹ The ambient temperature of a PXI system is defined as the temperature at the chassis fan inlet (air intake).

- ² Accuracy is specified for no load output configurations. Refer to Load Regulation and Remote Sense in the **Additional Specifications** section for additional accuracy derating and conditions.
- ³ Current limit set to ≥ 1 mA and $\geq 10\%$ of the selected current limit range.
- ⁴ 20 Hz to 20 MHz bandwidth. PXIe-4145 configured for normal transient response.
- ⁵ When source-measuring, both the NI-DCPowerSource Delay and Aperture Time properties affect the sampling rate. When taking a measure record, only the Aperture Time property affects the sampling rate.
- ⁶ Load dependent settling time is not included. Normal DC noise rejection is used.
- ⁷ As the source delay is adjusted or if advanced sequencing is used, maximum source update rates may vary.
- ⁸ Pulse widths and logic levels are compliant with **PXI Express Hardware Specification Revision 1.0 ECN 1**.
- ⁹ Input triggers can come from any source (PXI trigger or software trigger) and be exported to any PXI trigger line. This allows for easier multi-board synchronization regardless of the trigger source.